

## N-channel 40 V, 2.2 mΩ typ., 32 A STripFET™ F5 Power MOSFET in a PowerFLAT™ 5x6 package

Datasheet - production data

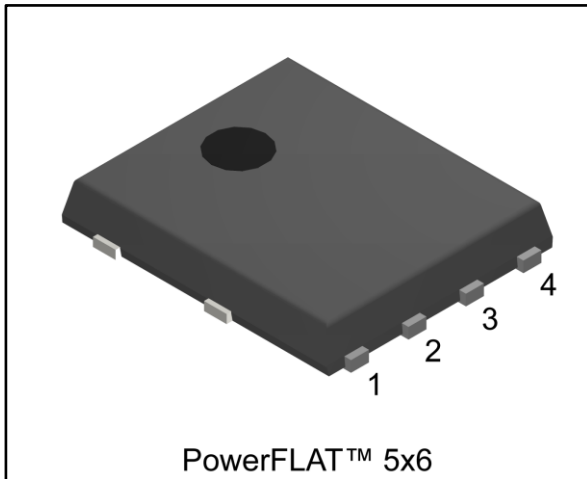
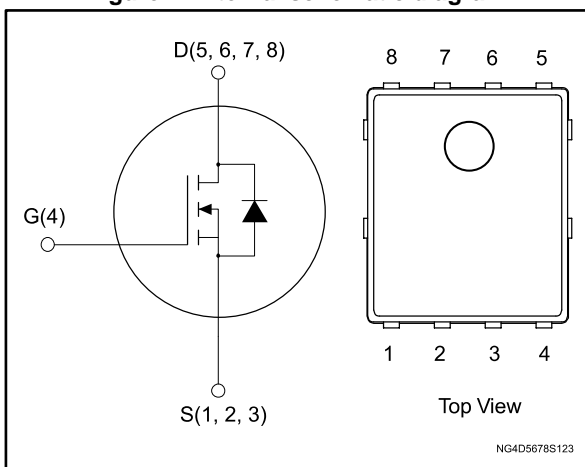


Figure 1: Internal schematic diagram



### Features

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>B</sub>
STL140N4LLF5	40 V	2.75 mΩ	32 A

- Low on-resistance R<sub>DS(on)</sub>
- High avalanche ruggedness
- Low gate drive power loss

### Applications

- Switching applications

### Description

This N-channel Power MOSFET is developed using the STripFET™ F5 technology and has been optimized to achieve very low on-state resistance, contributing to a FoM that is among the best in its class.

Table 1: Device summary

Order code	Marking	Package	Packing
STL140N4LLF5	140N4LF5	PowerFLAT™ 5x6	Tape and reel

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# 1 Electrical ratings

**Table 2: Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage	40	V
$V_{GS}$	Gate-source voltage	$\pm 22$	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$	140	A
$I_D^{(1)}$	Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$	88	A
$I_D^{(2)}$	Drain current (continuous) at $T_{pcb} = 25\text{ }^\circ\text{C}$	32	A
$I_D^{(2)}$	Drain current (continuous) at $T_{pcb} = 100\text{ }^\circ\text{C}$	20	A
$I_{DM}^{(3)}$	Drain current (pulsed)	128	A
$P_{TOT}^{(1)}$	Total dissipation at $T_C = 25\text{ }^\circ\text{C}$	80	W
$P_{TOT}^{(2)}$	Total dissipation at $T_{pcb} = 25\text{ }^\circ\text{C}$	4	W
$T_{stg}$	Storage temperature range	-55 to 150	$^\circ\text{C}$
$T_j$	Operating junction temperature range		

**Notes:**

- (1) This value is rated according to  $R_{thj-case}$ .  
 (2) This value is rated according to  $R_{thj-pcb}$ .  
 (3) Pulse width limited by safe operating area.

**Table 3: Thermal data**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case	1.56	$^\circ\text{C/W}$
$R_{thj-pcb}^{(1)}$	Thermal resistance junction-pcb	31.3	$^\circ\text{C/W}$

**Notes:**

- (1) When mounted on FR-4 board of 1 inch<sup>2</sup>, 2 oz Cu t <10 sec

**Table 4: Avalanche characteristics**

Symbol	Parameter	Value	Unit
$I_{AV}$	Not-repetitive avalanche current, (pulse width limited by $T_{jmax}$ )	16	A
$E_{AS}$	Single pulse avalanche energy (starting $T_J = 25\text{ }^\circ\text{C}$ , $I_D = I_{AV}$ , $V_{DD} = 24\text{ V}$ )	300	mJ

## 2 Electrical characteristics

$T_C = 25\text{ °C}$  unless otherwise specified

**Table 5: On/off-state**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0\text{ V}$ , $I_D = 250\text{ }\mu\text{A}$	40			V
$I_{DSS}$	Zero gate voltage drain current	$V_{GS} = 0\text{ V}$ , $V_{DS} = 40\text{ V}$			1	$\mu\text{A}$
		$V_{GS} = 0\text{ V}$ , $V_{DS} = 40\text{ V}$ , $T_C = 125\text{ °C}$ <sup>(1)</sup>			10	$\mu\text{A}$
$I_{GSS}$	Gate body leakage current	$V_{DS} = 0\text{ V}$ , $V_{GS} = \pm 22\text{ V}$			$\pm 100$	$\mu\text{A}$
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250\text{ }\mu\text{A}$	1			V
$R_{DS(on)}$	Static drain-source on-resistance	$V_{GS} = 10\text{ V}$ , $I_D = 16\text{ A}$		2.2	2.75	$\text{m}\Omega$
		$V_{GS} = 4.5\text{ V}$ , $I_D = 16\text{ A}$		2.4	3.1	$\text{m}\Omega$

**Notes:**

<sup>(1)</sup>Defined by design, not subject to production test.

**Table 6: Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$ , $V_{GS} = 0\text{ V}$	-	5900	-	$\text{pF}$
$C_{oss}$	Output capacitance		-	870	-	$\text{pF}$
$C_{rss}$	Reverse transfer capacitance		-	130	-	$\text{pF}$
$Q_g$	Total gate charge	$V_{DD} = 15\text{ V}$ , $I_D = 32\text{ A}$ $V_{GS} = 0$ to $4.5\text{ V}$ , see ( <a href="#">Figure 14: "Test circuit for gate charge behavior"</a> )	-	45	-	$\text{nC}$
$Q_{gs}$	Gate-source charge		-	14	-	$\text{nC}$
$Q_{gd}$	Gate-drain charge		-	17	-	$\text{nC}$
$R_G$	Gate input resistance	$f = 1\text{ MHz}$ , gate DC bias = $0\text{ V}$ , test signal level = $20\text{ mV}$ , $I_D = 0\text{ A}$	-	1.2	-	$\Omega$

**Table 7: Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 15\text{ V}$ , $I_D = 16\text{ A}$ , $R_G = 4.7\text{ }\Omega$ $V_{GS} = 10\text{ V}$ , (see <a href="#">Figure 13: "Test circuit for resistive load switching times"</a> and <a href="#">Figure 18: "Switching time waveform"</a> )	-	19	-	ns
$t_r$	Rise time		-	29	-	ns
$t_{d(off)}$	Turn-off delay time		-	90	-	ns
$t_f$	Fall time		-	21	-	ns

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Forward on voltage		-		32	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		128	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 32 \text{ A}$ , $V_{GS} = 0 \text{ V}$	-		1.1	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 32 \text{ A}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ , $V_{DD} = 25 \text{ V}$ (see <a href="#">Figure 15: "Test circuit for inductive load switching and diode recovery times"</a> )	-	44		ns
$Q_{rr}$	Reverse recovery charge		-	57		nC
$I_{RRM}$	Reverse recovery current		-	2.6		A

**Notes:**

(1)Pulse width limited by safe operating area.

(2)Pulsed: pulse duration=300 $\mu\text{s}$ , duty cycle 1.5%.

## 2.1 Electrical characteristics (curves)

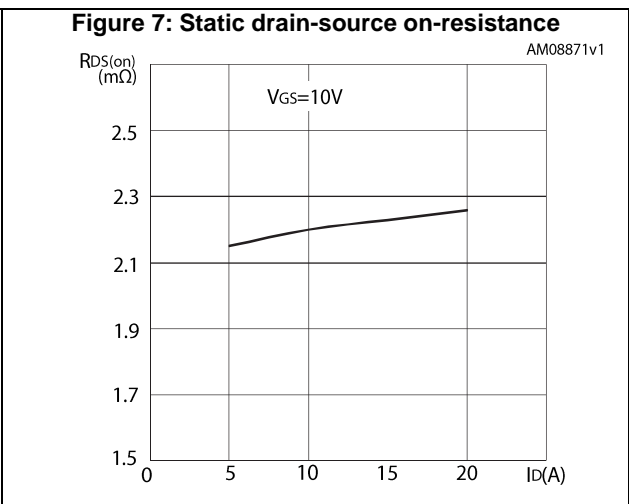
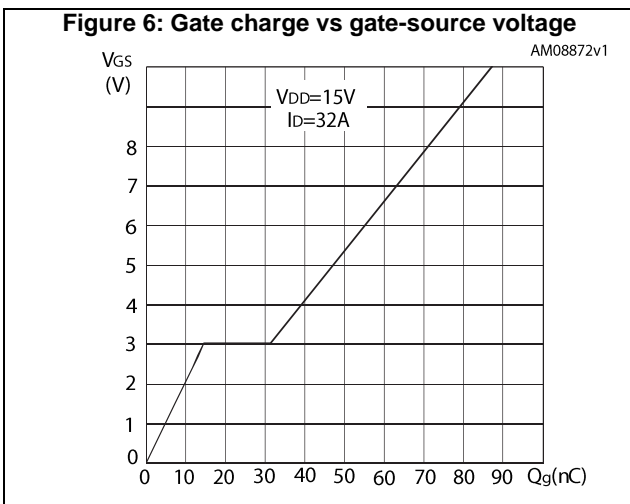
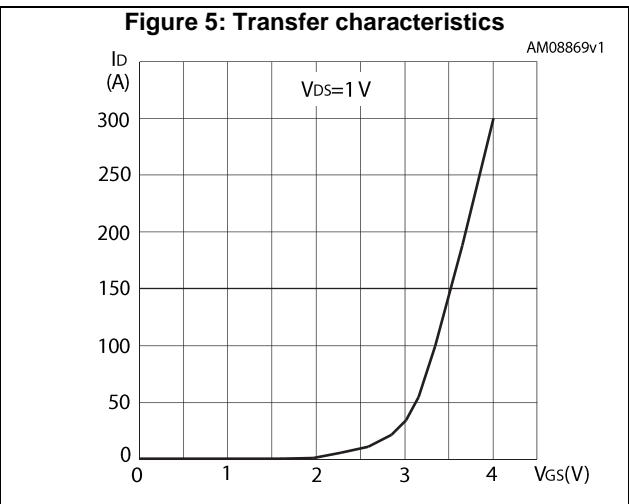
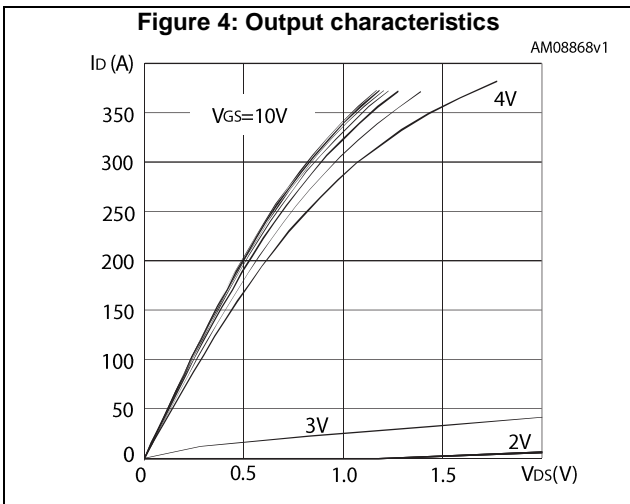
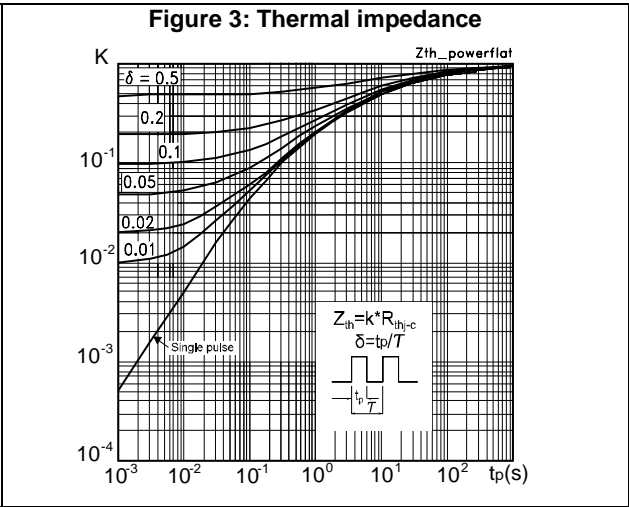
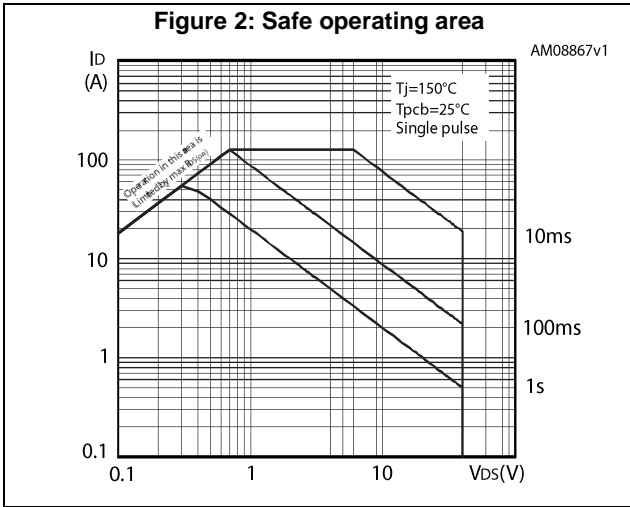


Figure 8: Capacitance variations

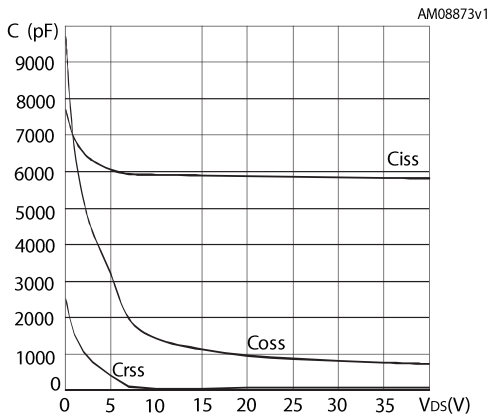


Figure 9: Normalized gate threshold voltage vs temperature

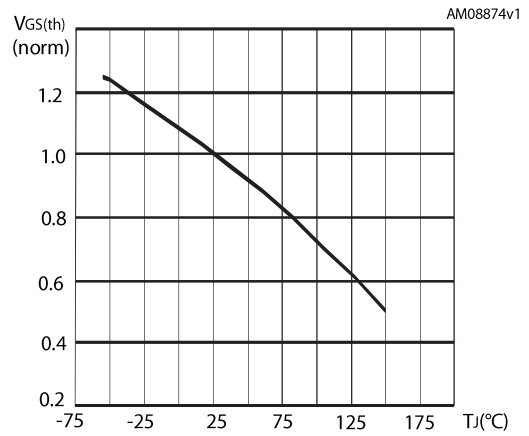


Figure 10: Normalized on-resistance vs temperature

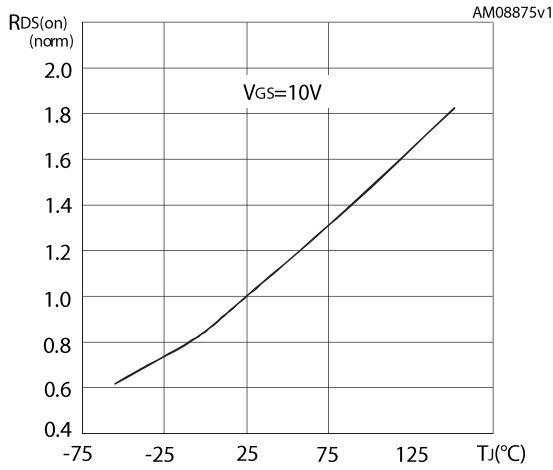


Figure 11: Normalized  $V_{(BR)DSS}$  vs temperature

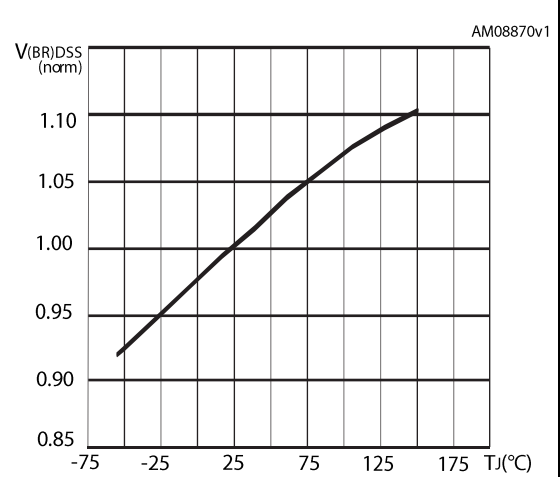
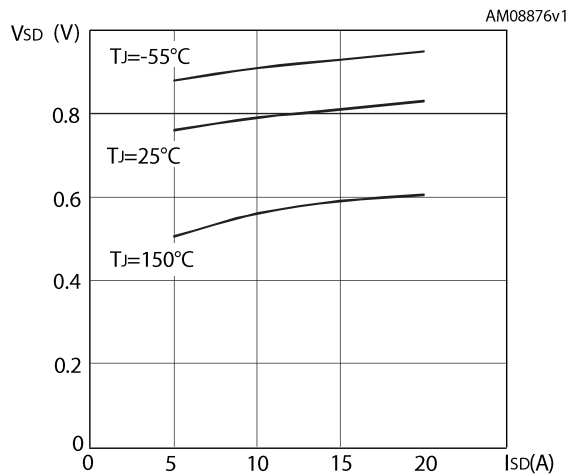
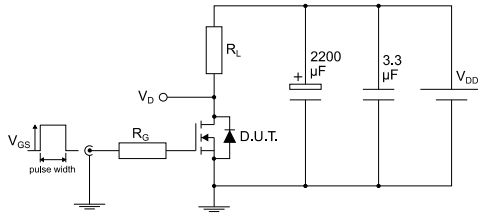


Figure 12: Source- drain diode forward characteristics



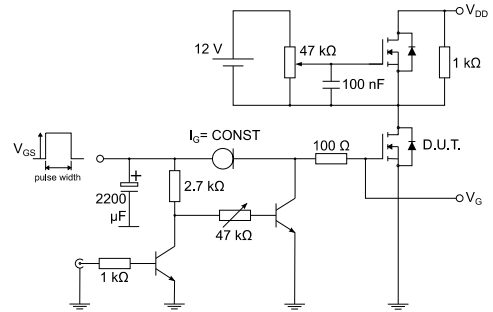
### 3 Test circuits

**Figure 13: Test circuit for resistive load switching times**



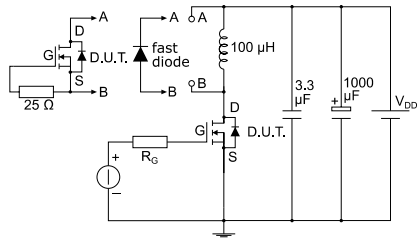
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**Figure 14: Test circuit for gate charge behavior**



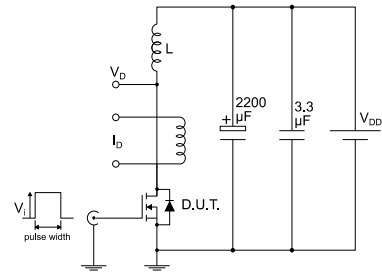
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**Figure 15: Test circuit for inductive load switching and diode recovery times**



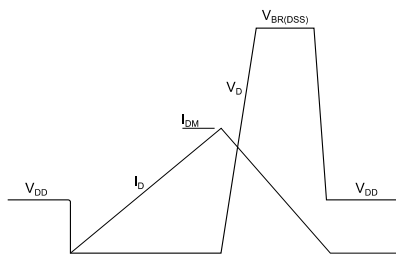
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**Figure 16: Unclamped inductive load test circuit**



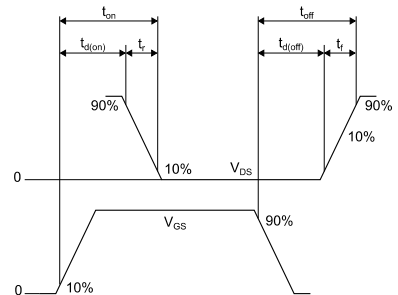
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**Figure 17: Unclamped inductive waveform**



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**Figure 18: Switching time waveform**



AM01473v1



## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

### 4.1 PowerFLAT™ 5x6 type C package information

Figure 19: PowerFLAT™ 5x6 type C package outline

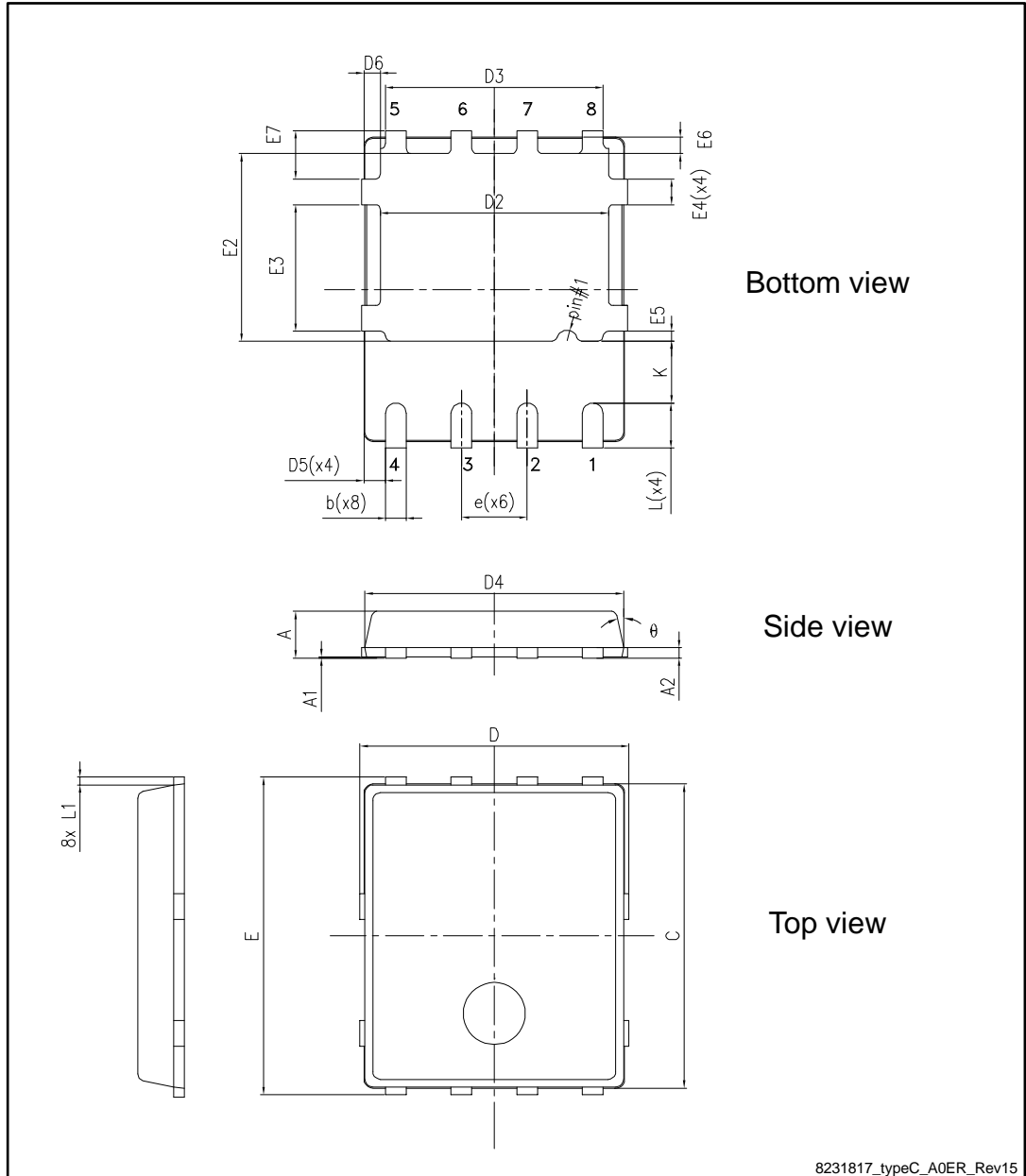
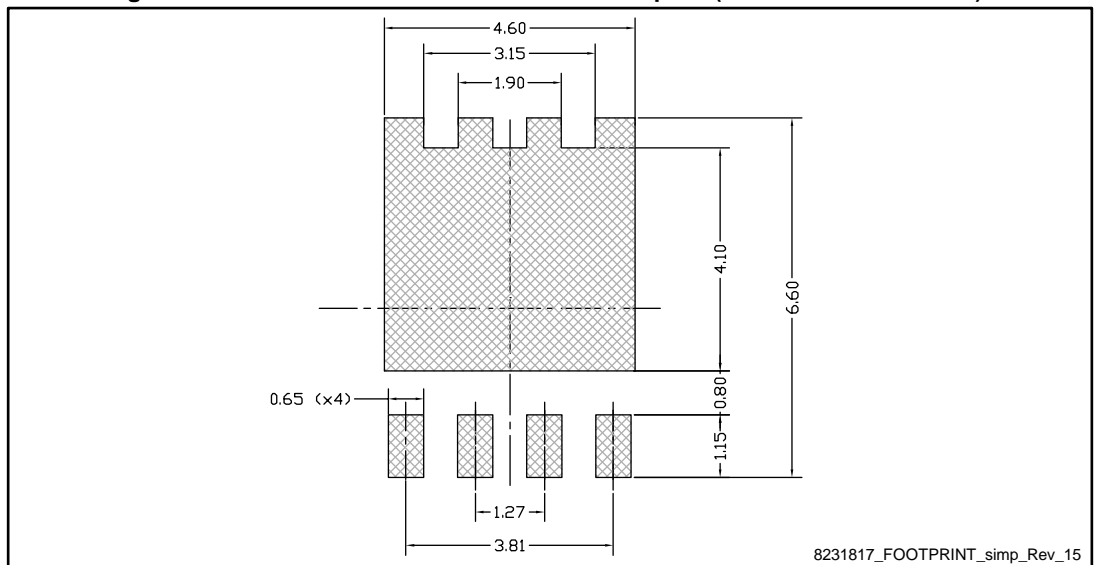


Table 9: PowerFLAT™ 5x6 type C package mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	0.80		1.00
A1	0.02		0.05
A2		0.25	
b	0.30		0.50
C	5.80	6.00	6.20
D	5.00	5.20	5.40
D2	4.15		4.45
D3	4.05	4.20	4.35
D4	4.80	5.00	5.20
D5	0.25	0.40	0.55
D6	0.15	0.30	0.45
e		1.27	
E	5.95	6.15	6.35
E2	3.50		3.70
E3	2.35		2.55
E4	0.40		0.60
E5	0.08		0.28
E6	0.20	0.325	0.45
E7	0.75	0.90	1.05
K	1.05		1.35
L	0.725		1.025
L1	0.05	0.15	0.25
θ	0°		12°

Figure 20: PowerFLAT™ 5x6 recommended footprint (dimensions are in mm)



### 4.2 PowerFLAT™ 5x6 packing information

Figure 21: PowerFLAT™ 5x6 tape (dimensions are in mm)

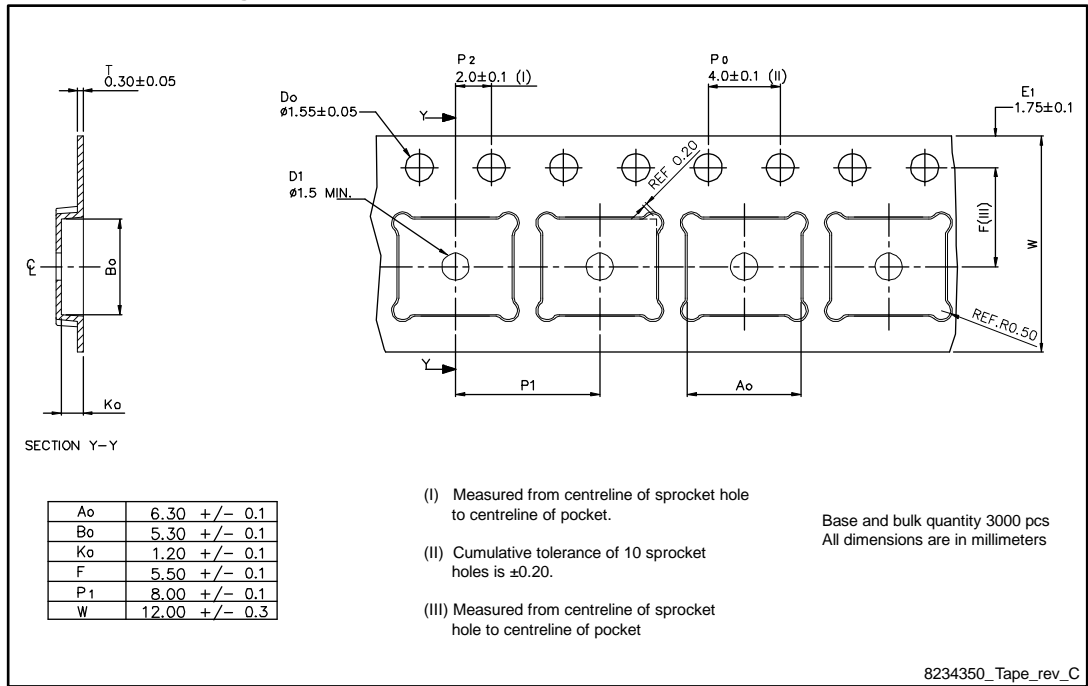


Figure 22: PowerFLAT™ 5x6 package orientation in carrier tape

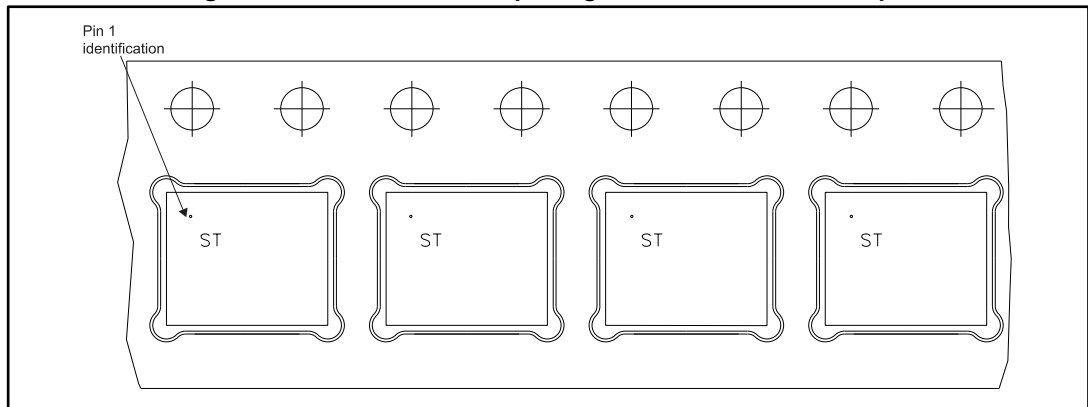
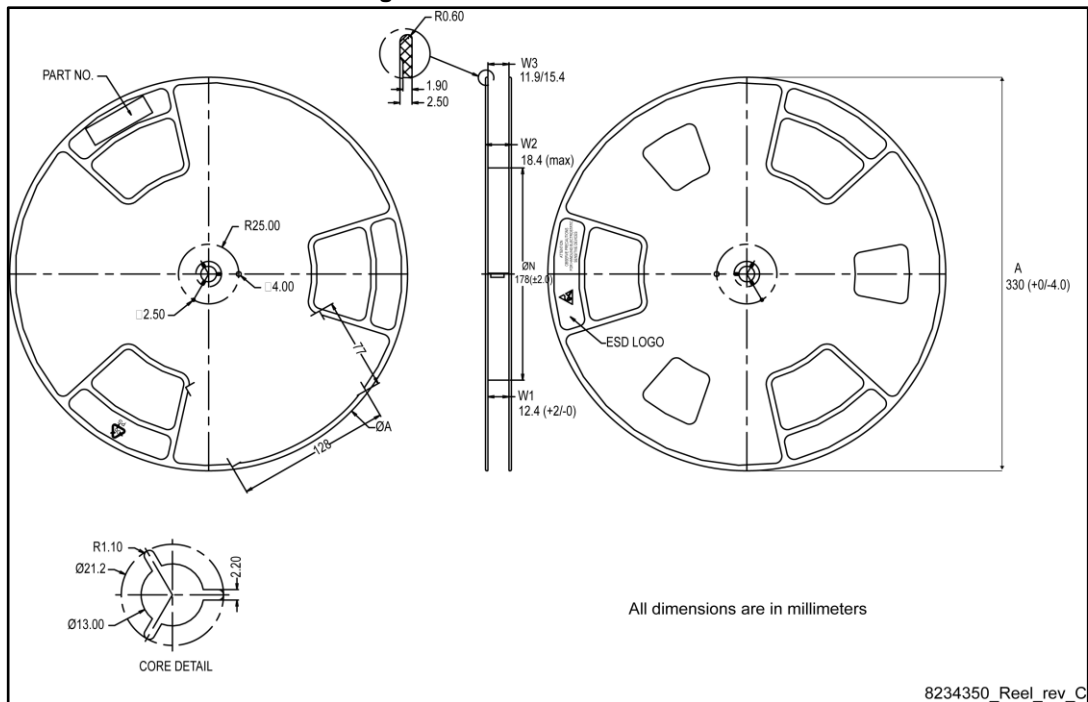


Figure 23: PowerFLAT™ 5x6 reel



## 5 Revision history

Table 10: Document revision history

Date	Revision	Changes
03-Jun-2010	1	First release.
29-Apr-2011	2	Document status promoted from preliminary data to datasheet.
10-Nov-2011	3	Section 4: Package mechanical data has been updated. Minor text changes.
08-Aug-2017	4	Modified <a href="#">Table 1: "Device summary"</a> . Updated <a href="#">Section 5: "Package information"</a> . Minor text changes.

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